Beam Induced Fluorescence Monitors

BIF[®], FPM[®], BPL[®], SPM[®], OBPM[®], VPM[®], RGM[®]...



ASSOCIATION



DIPAC2011 – May 18th Frank Becker – GSI Beam Diagnostics

Outline



- Motivation & Introduction
 - Benefit of non-intercepting profile measurement
 - Detection priciple, components and functionality
- Physics Results of Research
 - Estimation of the photon yield
 - Parameters to be optimized
 - Limiting factors (yield, radiation, displacement)
- Overview of Realizations
 - Transport & LINAC installations
 - Synchrotron installations
- Conclusion



- N₂-dominated for $p \ge 10^{-8}$ mbar, H₂-dominated for lower p
- Atomic collisions drive $-dE/dx \rightarrow electronic$ stopping
- Processes to be observed: ionization and fluorescence...



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Ionization Profile Monitor





- Gas-ions accelerated in homogeneous E-field vs. spatially resolving sensor
- \pm 6 kV accelerating voltage \rightarrow E = 70 kV/m
- \bullet TOF N_2^+ ions \sim 100 ns
- 4π -acceptance \rightarrow all ions
- MCP-amplification ~10⁶
- Stripline/optical readout

Sensitive profile monitor suitable for synchrotrons

[DIPAC: TUPD51, Giacomini]

Beam Induced Fluorescence





How a Beam Profile is Obtained





How a Beam Profile is Obtained



200 AMeV Xe⁴⁸⁺, 20 pulses of 10^9 Ions in 5 \cdot 10^{-4}



BIF- and SEM-profiles in accordance with each other, $\Delta\sigma/\sigma \leq 10\%$

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Beam Profile Comparison



BIF- and SEM-profiles in accordance with each other, $\Delta\sigma/\sigma \le 10\%$ BIF- and IPM-profiles agree very well [DIPAC: WEOA03 Egberts]

Detection Principle





Detection Principle – Digital Camera





Solid angle limited by view-port/iris opening Slit Photon $GAS(N_2)$ ADC Ω **BEAM** Lens system Atomic collisions heavy ions $\Leftrightarrow N_2$ $dE/dx \rightarrow excitation$ Photomultiplier tube HV \mapsto amplification ~10⁶ fluorescence trans. Single photon counting! N₂⁺: 391, 427 nm,...

Detection Principle – Slit with PMT

Detection Principle – PMT Array





Detection Principle – 2 Dimensional



Benefit of the BIF-monitor



- Short insertion-length
- No mechanical parts inside the vacuum
- Gas pressure adjusts signal strength
- Optical system can be tailored to application
- Components of the shelf
 - Lens with motorized iris
 - V-stack image intesifier single photon counting
 - Digital 12-bit VGA-cam with FireWire-interface

25 cm

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What is next:



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Number of Detected Photons



$$Y_{photon} = \sigma_{photon}(E,\bar{q}) N_{Ion} \Delta s \Omega P_{Det} \rho$$

The Given Parameters



$$Y_{photon} = (\sigma_{photon}(E,\bar{q}) N_{Ion}) \Delta s \Omega P_{Det} \rho$$



- Cross sections experimentally determined at PS-Booster/PS:
- dE/dx energy ependency but more data points required...
- Source, LINAC/Cycl., Synchr.
- Gas species determines light yield and energy loss

We like to have the maximum number of photons per dE/dx

Results Spectroscopy – Photon Yield





Results Spectroscopy – Profile Reading



S⁶⁺ Ions @ 5 AMeV in 10^{-3} mbar gas:

- Fluorescence for rare gases and N₂: near UV to green
- Intensive lines and highest Y for N₂



 Profile reading is equal for all gases except for He

 N_2^+ and Xe⁺ are recommended!

[F. Becker et al. BIW 2010]

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Parameters to be Optimized $Y_{photon} = \sigma_{photon}(E, \bar{q}) N_{Ion} \Delta s \Omega P_{Det} \rho$





Δd should cover the beam width $\rightarrow \Omega$ is limited due to κ_{min}



Δd should cover the beam width $\rightarrow \Omega$ is limited due to κ_{min}

Pressure-Variation

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[DIPAC'07, F. Becker et al.]

SIS-18 (200 AMeV) UNILAC (4,5 AMeV) 10⁶ קידם 102 statistical error single sequence average value average value <u>...</u> 10⁴ fit: y=a*x^b fit: y=a*x^b signal signal b=1.08(5) b = 1.02(5)10² -5 +++++++++ 30 25 profile FWHM [mm] profile FWHM 15 10 2 3 -2 10 1 $2.10^9 \text{ Xe}^{48+} @ 200 \text{ AMeV} und$ $10^{10} \text{ Ni}^{6+} @ 4.54 \text{ AMeV} und$ HEBT: LINAC: p = 10⁻³ mbar bis p = 3 mbar $p = 10^{-6}$ mbar bis $p = 10^{-3}$ mbar 0 0 11111 Π 10° -3 10 10 10 10 10 N, pressure [mbar] N, pressure [mbar]

Light yield ~ p and σ = constant \rightarrow p is a free parameter

Gas Dosing Systems





Limiting Factors

GSİ

 Photon Yield shotnoise, statistics



 Radiation induced noise & damage



 Displacement process, lifetime, particle mass...



Limiting Factors

Improvements



 Photon Yield shotnoise, statistics

 Optimized Geometry + Optics and single photon counting

 Radiation induced noise & damage



 Displacement process, lifetime, particle mass...







 Photon Yield shotnoise, statistics

 Optimized Geometry + Optics and single photon counting

 Radiation induced noise & damage Radiation tolerant components and sufficient shielding

 Displacement process, lifetime, particle mass...





process, lifetime, particle mass...

excitation by electrons, heavy species with short lifetime, e.g. Xe+

Shielding-Concept with Image-Guide



- Shielding walls or blocks $1m^3 \rightarrow \ge 90\%$ reduction
- Image transport with relay optics or image guide
- Radiation hard components and optics are recommended: ICID, CMOS, quartz fibers...
 - [C. Zamantzas, DIPAC][F. Senée, DIPAC-09][F. Becker, BIW-08]



Diagnostics with the Eye :-)





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Decreasing Kr-Pressure 1000 – 1 mbar 🛛 🖬 🎞



3,75 MeV/u Ø 4 mm 100 nA S⁷⁺ beam in 1000 - 1 mbar Krypton @ TU-Munich

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PSI Cyclotron and LEBT



Measurement of 10 luminescent profile monitors along the transport section. 870 keV, 13 mA DC proton beam in $\leqslant 10^{-5}$ mbar residual gas.

[Courtesy of R. Doelling, PSI]

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DIPAC: MOPD60 C. Andre]

 Typical gating times µs-ms 4 systems in operation

4

-

2 Systems in preparation

Single pulse operation

Profile-View software for online monitoring in the controls room [DIPAC 2009 R. Haseitl]

Ar * Gas Stripper Ar ""

BIF Setup at GSI-UNILAC

Horizontal ICCD MUCIS MEVVA Vertical ICCD

SIS18 1





IFMIF EVEDA – Prototype Testing







15 $\mu\,A$ D^{+} beam at 9 MeV/u in 7 \cdot 10^{4} mbar N_{2} gas (125 mA is intended)

[Courtesy of J.M. Carmona]

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FZ-Jülich COSY





- 1.5.10¹⁰ protons at 2.6 GeV/c cooler storage synchrotron, low p
- Pulsed piezo leak valve to minimize gas load (t_{min} ~1 ms)
- $p_{base} \sim 2 \cdot 10^{-9}$, $p_{measure} \sim 4 \cdot 10^{-8}$ mbar
- Integration time counteracts low p

[DIPAC: MOPD51 V. Kamerdzhiev]







IAP Frankfurt – Tomography



270° rotation



Tomography: 181 profile projection measured with rotating chamber:



- 2-dimensional density distributions
- High res. scanning, radon transform
- Non-invasive emittance determin.
- 120 keV, 200 mA H⁺, 5·10⁻⁵ mbar N₂

Reconstructed density distribution [DIPAC: TUBD60 & TUPD52 H. Reichau/C. Wagner]

CEA Saclay – Tomography







Projections and reconstruction (bottom) Diagnostic chamber with 6 equally spaced viewports for CCDs



- 2-dimensional density distributions
- Iterative Algebraic reconstruction technique (ART)
- Installed at BETSI source test bench
- 50 keV, 5 mA H⁺ beam, 5·10⁻⁵ mbar H₂

Conclusion



- Remarkable developments for:
 - Synchrotrons & transport to characterize intensive ion beams
- Results of research:
 - Signal-amplitude \rightarrow linear with p, dE/ds with E \rightarrow f = const.
 - $\hfill \ensuremath{\,\,}$ Profile-width \rightarrow does not depend on p \rightarrow p free parameter
 - Radiation-induced background $\rightarrow \sim E^2 \rightarrow$ shielding is mandatory
 - Rare gases (Kr, Xe) can replace $N_2 \rightarrow$ reduced profile errors
 - N₂ has highest fluorescence-efficiency per energy loss
- Successful implementation of BIF-monitors:
 - In the energy-range of 7,5 AkeV 450 AGeV
 - In transport sections and synchrotrons
 - Many innovative installations are in operation
 - The story goes on...



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Thank you for your attention! ©